

Search Notes

Application/Control No.

10/530,876

Examiner

Karen Cheng

Applicant(s)/Patent under
Reexamination

DORSCH ET AL.

Art Unit

1626

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN Structure Search (updated - see attached)	4/6/2007	KC